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Kind regards,

Team Nexperia

# PSMN1R6-30PL

## N-channel 30 V 1.7 m $\Omega$ logic level MOSFET

Rev. 02 — 25 June 2009

**Product data sheet** 

## 1. Product profile

#### 1.1 General description

Logic level N-channel MOSFET in TO220 package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

#### 1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for logic level gate drive sources

#### 1.3 Applications

- DC-to-DC converters
- Load switiching

- Motor control
- Server power supplies

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	-	30	V
I <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ;	<u>[1]</u>	-	-	100	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	306	W
Dynamic	characteristics						
$Q_{GD}$	gate-drain charge	$V_{GS}$ = 4.5 V; $I_D$ = 25 A; $V_{DS}$ = 15 V; see <u>Figure 14</u> ; see <u>Figure 15</u>		-	27	-	nC
Q <sub>G(tot)</sub>	total gate charge	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A};$ $V_{DS} = 15 \text{ V}; \text{ see } \frac{\text{Figure } 14}{\text{Figure } 14}$		-	101	-	nC
Static characteristics							
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C};$	[2]	-	1.4	1.7	mΩ

<sup>[1]</sup> Continuous current is limited by package.



<sup>[2]</sup> Measured 3 mm from package.

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N-channel 30 V 1.7 m $\Omega$  logic level MOSFET

## **Pinning information**

Table 2. **Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain	mb	D
3	S	source		$G \longrightarrow A$
mb	D	mounting base; connected to drain	1 2 3	mbb076 S
			SOT78 (TO-220AB; SC-46)	

#### **Ordering information** 3.

Table 3. **Ordering information** 

**Product data sheet** 

Type number	Package		
	Name	Description	Version
PSMN1R6-30PL	TO-220AB; SC-46	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

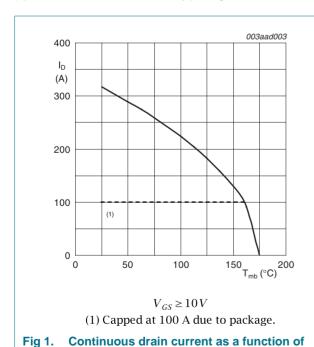
### 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Parameter	Conditions				
	Conditions		Min	Max	Unit
drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	30	V
drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$		-	30	V
gate-source voltage			-20	20	V
drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{Figure 1}};$	[1]	-	100	Α
	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; see <u>Figure 1</u> ;	[1]	-	100	Α
peak drain current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$ ; see <u>Figure 3</u>		-	1268	Α
total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	306	W
storage temperature			-55	175	°C
junction temperature			-55	175	°C
ain diode					
source current	$T_{mb} = 25  ^{\circ}C;$	[1]	-	100	Α
peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	1268	Α
ruggedness					
non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup}$ ≤ 30 V; $R_{GS}$ = 50 Ω; unclamped		-	1.7	J
	drain-gate voltage gate-source voltage drain current  peak drain current total power dissipation storage temperature junction temperature ain diode source current peak source current ruggedness non-repetitive drain-source avalanche	drain-gate voltage $T_j \ge 25  ^{\circ}\text{C};  T_j \le 175  ^{\circ}\text{C};  R_{GS} = 20  k\Omega$ gate-source voltage drain current $V_{GS} = 10  \text{V};  T_{mb} = 100  ^{\circ}\text{C};  \text{see } \frac{\text{Figure 1}}{\text{Figure 3}};$ peak drain current $t_p \le 10  \mu \text{s};  \text{pulsed};  T_{mb} = 25  ^{\circ}\text{C};  \text{see } \frac{\text{Figure 3}}{\text{Figure 3}}$ total power dissipation $T_{mb} = 25  ^{\circ}\text{C};  \text{see } \frac{\text{Figure 2}}{\text{Figure 2}}$ storage temperature junction temperature ain diode source current $T_{mb} = 25  ^{\circ}\text{C};$ peak source current $t_p \le 10  \mu \text{s};  \text{pulsed};  T_{mb} = 25  ^{\circ}\text{C}$ eruggedness non-repetitive $t_p \le 10  \mu \text{s};  \text{pulsed};  T_{mb} = 25  ^{\circ}\text{C};  t_p = 100  \text{A};  V_{sup} \le 30  \text{V};  V_{sup} \le 10  \text{C};  V_{sup} \le 10  \text{C};$	drain-gate voltage $T_j \ge 25$ °C; $T_j \le 175$ °C; $R_{GS} = 20$ k $\Omega$ gate-source voltage drain current $V_{GS} = 10$ V; $V_{Tmb} = 100$ °C; see Figure 1; [1] $V_{GS} = 10$ V; $V_{Tmb} = 25$ °C; see Figure 1; [1] peak drain current $V_{Tmb} = 25$ °C; see Figure 3 total power dissipation $V_{Tmb} = 25$ °C; see Figure 2 storage temperature junction temperature ain diode source current $V_{Tmb} = 25$ °C; see Figure 2 $V_{Tmb} = 25$ °C; see Figure 3 $V_{Tmb} = 25$ °C; see Figure 4 $V_{Tmb} = 25$ °C; see Figure 5 °C; see Figure 6 $V_{Tmb} = 25$ °C; see Figure 6 $V_{Tmb} = 25$ °C; see Figure 7 $V_{Tmb} = 25$ °C; see Figure 8 $V_{Tmb} = 25$ °C; see Figure 9 $V_{Tmb} = $	$ \begin{array}{llllllllllllllllllllllllllllllllllll$	drain-gate voltage $T_j \ge 25~^\circ C; T_j \le 175~^\circ C; R_{GS} = 20~k\Omega$ - 30 gate-source voltage -20 20 drain current $V_{GS} = 10~V; T_{mb} = 100~^\circ C; see~Figure~1;$ [1] - 100 $V_{GS} = 10~V; T_{mb} = 25~^\circ C; see~Figure~1;$ [1] - 100 peak drain current $V_p \le 10~\mu s; pulsed; T_{mb} = 25~^\circ C; see~Figure~3$ - 1268 total power dissipation $V_{mb} = 25~^\circ C; see~Figure~2$ - 306 storage temperature -55 175 junction temperature -55 175 ain diode source current $V_{mb} = 25~^\circ C; see~V_{mb} = 25~^\circ C; see~V_$

#### [1] Continuous current is limited by package.

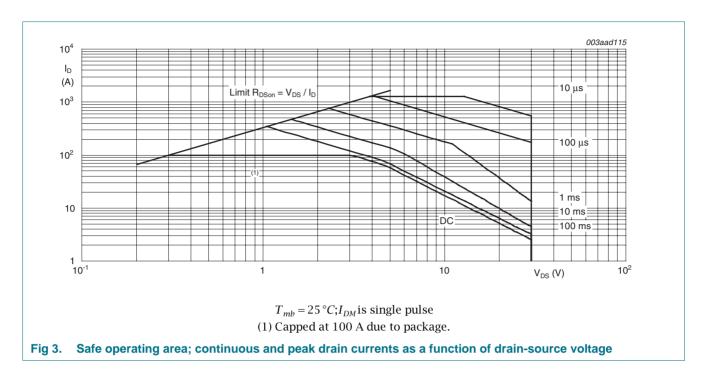


mounting base temperature

Fig 2. Normalized total power dissipation as a function of mounting base temperature

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#### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	0.22	0.49	K/W

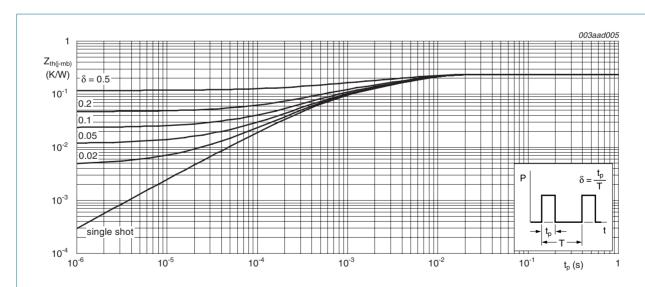


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

N-channel 30 V 1.7 m $\Omega$  logic level MOSFET

### 6. Characteristics

Table 6. Characteristics

Tested to JEDEC standards where applicable.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static cha	racteristics						
$V_{(BR)DSS}$	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$		30	-	-	V
	breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^{\circ}C$		27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 25 °C; see Figure 11; see Figure 12		1.3	1.7	2.15	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 12		0.5	-	-	V
		$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = -55 °C; see Figure 12		-	-	2.45	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	-	5	μA
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$		-	-	150	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 16 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	-	100	nA
		$V_{GS} = -16 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	-	100	nA
R <sub>DSon</sub>	drain-source on-state	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C}$		-	1.6	2.1	mΩ
	resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 100 ^{\circ}\text{C}; \text{see}$ Figure 13		-	-	2.3	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$	[1]	-	1.4	1.7	mΩ
$R_G$	gate resistance	f = 1 MHz		-	0.98	-	Ω
Dynamic (	characteristics						
Q <sub>G(tot)</sub>	total gate charge	$I_D = 25 \text{ A}$ ; $V_{DS} = 15 \text{ V}$ ; $V_{GS} = 10 \text{ V}$ ; see Figure 14; see Figure 15		-	212	-	
		$I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V$		-	193	-	nC
		$I_D = 25 \text{ A}$ ; $V_{DS} = 15 \text{ V}$ ; $V_{GS} = 4.5 \text{ V}$ ; see Figure 14		-	101	-	nC
$Q_{GS}$	gate-source charge	$I_D$ = 25 A; $V_{DS}$ = 15 V; $V_{GS}$ = 4.5 V; see Figure 14; see Figure 15		-	33	-	nC
Q <sub>GS(th)</sub>	pre-threshold gate-source charge	$I_D = 25 \text{ A}$ ; $V_{DS} = 15 \text{ V}$ ; $V_{GS} = 4.5 \text{ V}$ ; see Figure 14		-	20	-	nC
Q <sub>GS(th-pl)</sub>	post-threshold gate-source charge			-	13	-	nC
$Q_{GD}$	gate-drain charge	$I_D$ = 25 A; $V_{DS}$ = 15 V; $V_{GS}$ = 4.5 V; see Figure 14; see Figure 15		-	27	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	V <sub>DS</sub> = 15 V; see <u>Figure 14</u>		-	2.5	-	V
C <sub>iss</sub>	input capacitance	$V_{DS} = 12 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$		-	12493	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 16</u>		-	2486	-	pF
C <sub>rss</sub>	reverse transfer capacitance			-	1034	-	pF

Table 6. Characteristics ... continued

Tested to JEDEC standards where applicable.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$t_{d(on)}$	turn-on delay time	$V_{DS}$ = 12 V; $R_L$ = 0.5 $\Omega$ ; $V_{GS}$ = 4.5 V; $R_{G(ext)}$ = 4.7 $\Omega$	-	104	-	ns
t <sub>r</sub>	rise time		-	163	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	174	-	ns
t <sub>f</sub>	fall time		-	87	-	ns
Source-dr	rain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 17	-	0.77	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 50 \text{ A}; \text{ d}I_S/\text{d}t = -100 \text{ A/}\mu\text{s}; \text{ V}_{GS} = 0 \text{ V}; \\ \text{V}_{DS} = 15 \text{ V}$	-	64	-	ns
Qr	recovered charge		-	79	-	nC

#### [1] Measured 3 mm from package.

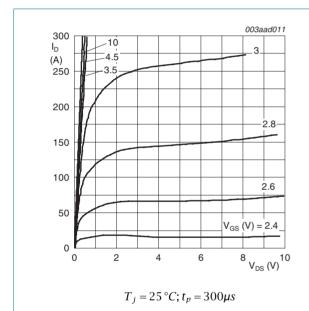


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

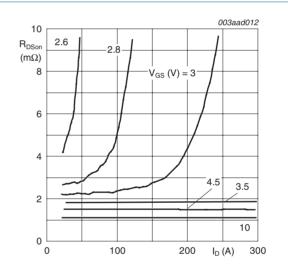
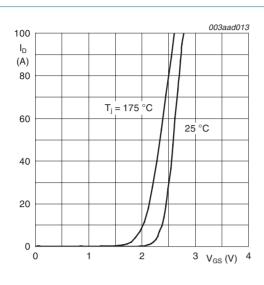


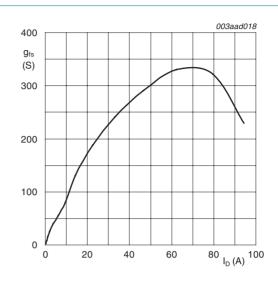
Fig 6. Drain-source on-state resistance as a function of drain current; typical values

 $T_i = 25 \,^{\circ}C$ 



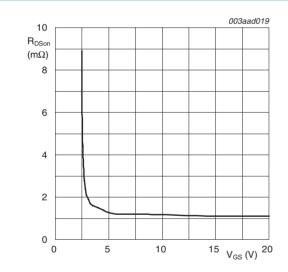
 $V_{DS} = 15V$ 

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values



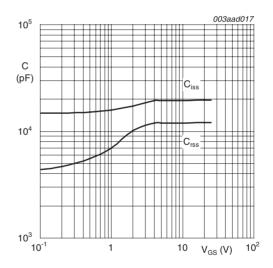
$$T_j = 25 \,{}^{\circ}C; V_{DS} = 15 \, V$$

Fig 8. Forward transconductance as a function of drain current; typical values



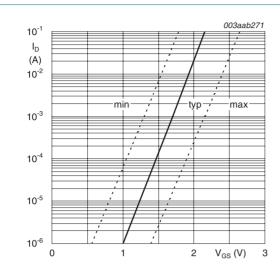
 $T_i = 25 \,^{\circ}C; I_D = 25A$ 

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values



$$V_{DS} = 0V; f = 1MHz$$

Fig 10. Input and reverse transfer capacitances as a function of gate-source voltage; typical values



 $T_j = 25 \,^{\circ}C; V_{DS} = 5 \, V$ 

Fig 11. Sub-threshold drain current as a function of gate-source voltage

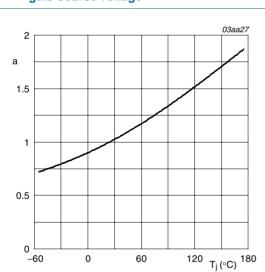
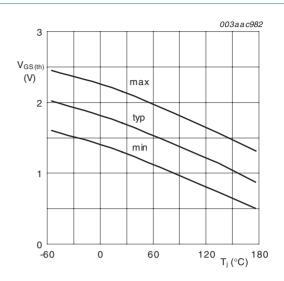


Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature



 $I_D = 1 \, mA; V_{DS} = V_{GS}$ 

Fig 12. Gate-source threshold voltage as a function of junction temperature

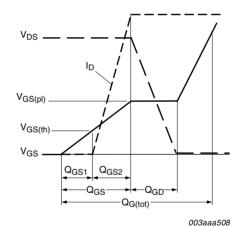


Fig 14. Gate charge waveform definitions

#### N-channel 30 V 1.7 mΩ logic level MOSFET

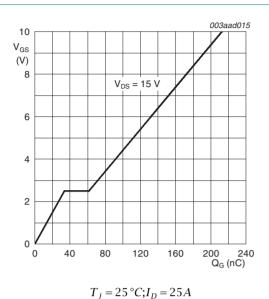
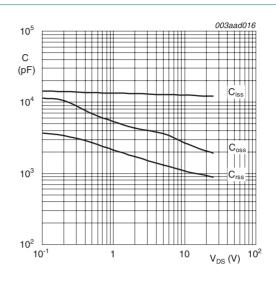


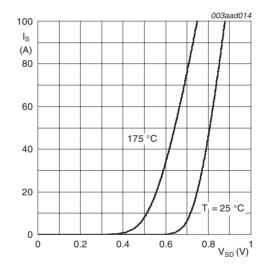
Fig 15. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$ 

Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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 $V_{GS} = 0V$ 

Fig 17. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

### 7. Package outline

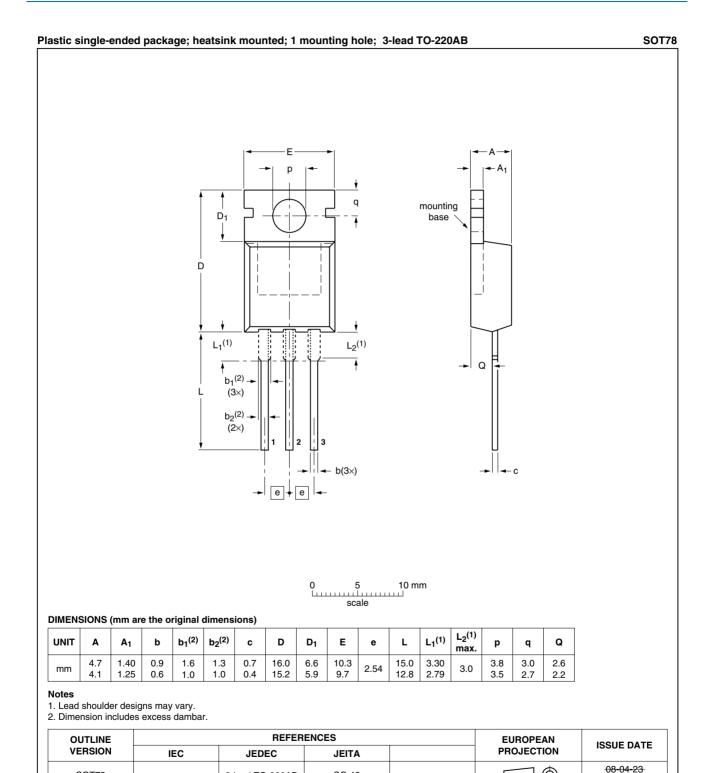


Fig 18. Package outline SOT78 (TO-220AB)

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SC-46

3-lead TO-220AB

SOT78

08-06-13



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N-channel 30 V 1.7 m $\Omega$  logic level MOSFET

## **Revision history**

#### Table 7. **Revision history**

**Product data sheet** 

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN1R6-30PL_2	20090625	Product data sheet	-	PSMN1R6-30PL_1
Modifications:	<ul> <li>Data sheet</li> </ul>	status changed from obj	ective to product.	
	<ul> <li>Various cor</li> </ul>	ntent changes.		
PSMN1R6-30PL_1	20090518	Objective data sheet	-	-

#### N-channel 30 V 1.7 mΩ logic level MOSFET

### 9. Legal information

#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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## PSMN1R6-30PL

#### N-channel 30 V 1.7 m $\Omega$ logic level MOSFET

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